

● General Description

The AGM1099EY combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

This device is ideal for load switch and battery protection applications.

● Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance
- 100% Avalanche tested
- 100% DVDS tested

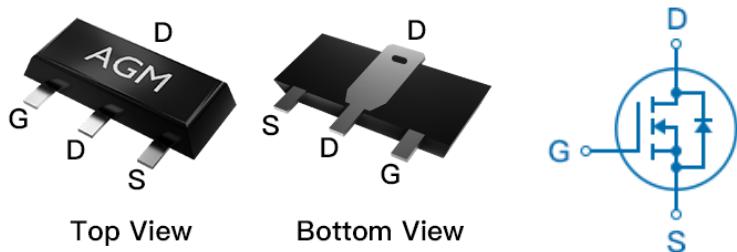
● Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

Product Summary

| BVDSS | RDS(on) | ID |
|-------|---------|------|
| 100V | 92mΩ | 5.0A |

SOT-89 Pin Configuration



Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|----------------|-----------|----------------|-----------|------------|----------|
| AGM1099EY | AGM1099EY | SOT-89 | 330mm | 12mm | 3000 |

Table 1. Absolute Maximum Ratings (TA=25°C)

| Symbol | Parameter | Value | Unit |
|-------------|---|------------|------|
| VDS | Drain-Source Voltage (VGS=0V) | 100 | V |
| VGS | Gate-Source Voltage (VDS=0V) | ±20 | V |
| ID | Drain Current-Continuous(TA=25°C) (Note 1) | 5.0 | A |
| | Drain Current-Continuous(TA=100°C) | 3.2 | A |
| IDM (pulse) | Drain Current-Pulsed (Note 2) | 20 | A |
| PD | Maximum Power Dissipation(TA=25°C) | 3.1 | W |
| EAS | Avalanche energy (Note 3) | 3.2 | mJ |
| TJ,TSTG | Operating Junction and Storage Temperature Range | -55 To 150 | °C |

Table 2. Thermal Characteristic

| Symbol | Parameter | Typ | Max | Unit |
|------------------|---|-----|-----|------|
| R _{θJA} | Thermal Resistance Junction-ambient (Steady State) ¹ | --- | 40 | °C/W |

Table 3. Electrical Characteristics (TJ=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---|----------------------------------|-------------------------------------|-----|------|------|------|
| On/Off States | | | | | | |
| BVDSS | Drain-Source Breakdown Voltage | VGS=0V ID=250μA | 100 | -- | -- | V |
| IDSS | Zero Gate Voltage Drain Current | VDS=100V, VGS=0V | -- | -- | 1 | μA |
| IGSS | Gate-Body Leakage Current | VGS=±20V, VDS=0V | -- | -- | ±100 | nA |
| VGS(th) | Gate Threshold Voltage | VDS=VGS, ID=250μA | 1.2 | 1.7 | 2.2 | V |
| gFS | Forward Transconductance | VDS=5V, ID=3A | -- | 2 | -- | S |
| RDS(on) | Drain-Source On-State Resistance | VGS=10V, ID=4A | -- | 92 | 115 | mΩ |
| | | VGS=4.5V, ID=3A | -- | 108 | 125 | mΩ |
| Dynamic Characteristics | | | | | | |
| Ciss | Input Capacitance | VDS=50V, VGS=0V, F=1MHZ | -- | 182 | -- | pF |
| Coss | Output Capacitance | | -- | 30 | -- | pF |
| Crss | Reverse Transfer Capacitance | | -- | 3.6 | -- | pF |
| Rg | Gate resistance | VGS=0V, VDS=0V, f=1.0MHz | -- | 2.5 | -- | Ω |
| Switching Times | | | | | | |
| td(on) | Turn-on Delay Time | VGS=10V, VDS=50V, ID=5A, RGEN=5Ω | -- | 11 | -- | nS |
| tr | Turn-on Rise Time | | -- | 6.0 | -- | nS |
| td(off) | Turn-Off Delay Time | | -- | 30 | -- | nS |
| tf | Turn-Off Fall Time | | -- | 4.0 | -- | nS |
| Qg | Total Gate Charge | VGS=10V, VDS=50V, ID=5A | -- | 3.57 | -- | nC |
| Qgs | Gate-Source Charge | | -- | 0.76 | -- | nC |
| Qgd | Gate-Drain Charge | | -- | 0.71 | -- | nC |
| Source-Drain Diode Characteristics | | | | | | |
| ISD | Source-Drain Current(Body Diode) | | -- | -- | 5.0 | A |
| VSD | Forward on Voltage | VGS=0V, IS=4A | -- | -- | 1.2 | V |
| trr | Reverse Recovery Time | IF=4A, dl/dt=100A/μs , TJ=25°C | -- | 50 | -- | ns |
| Qrr | Reverse Recovery Charge | | -- | 102 | -- | nc |

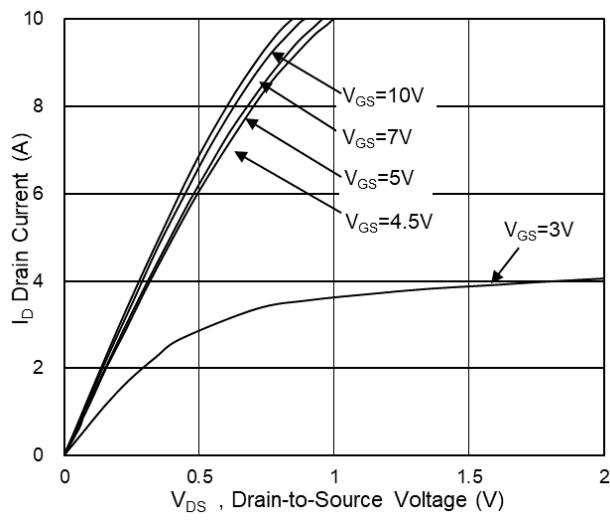
Notes 1.The maximum current rating is package limited.

Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature

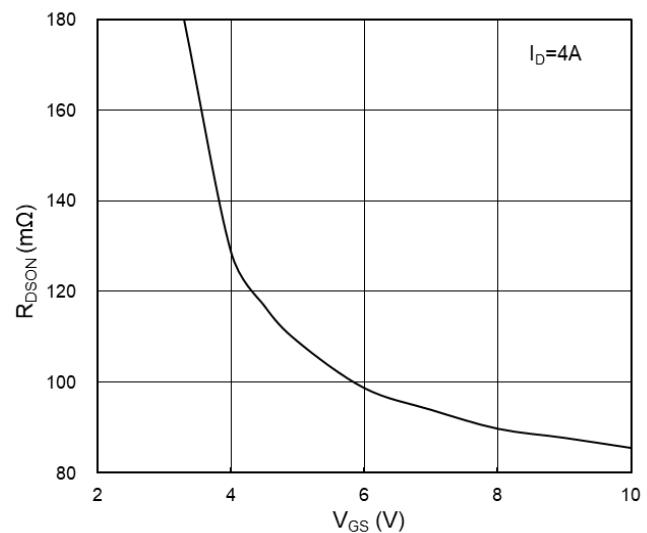
Notes 3.EAS condition: TJ=25°C , VDD=50V,Vgs=10V , ID=3.6A,L=0.5mH,RG=25ohm

Characteristics Curve:

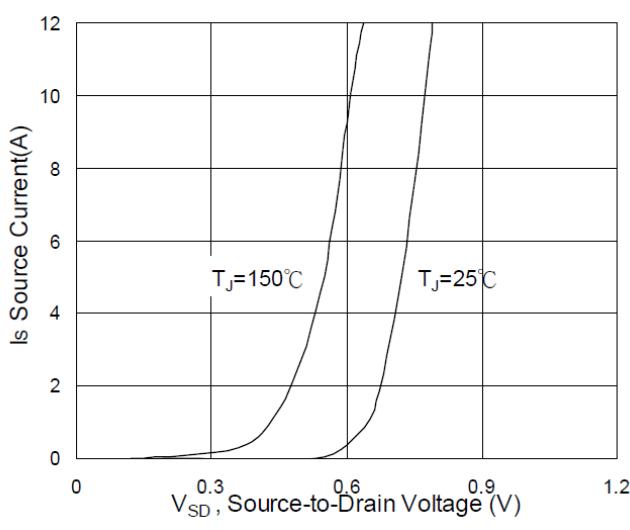
Typ. Output Characteristics



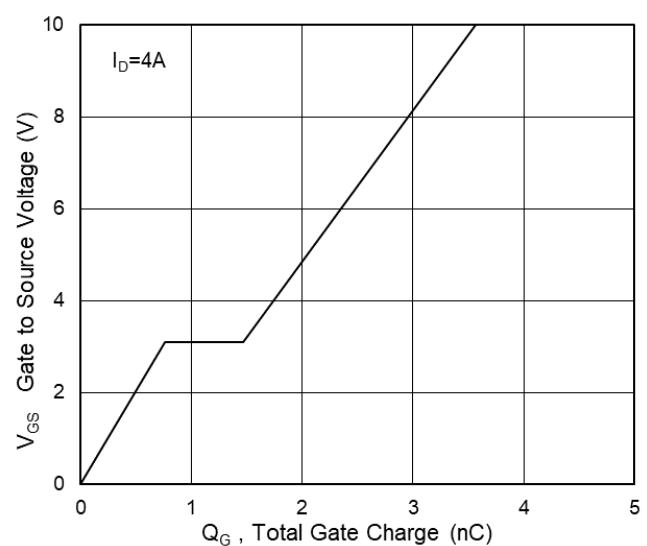
On-Resistance vs G-S Voltage

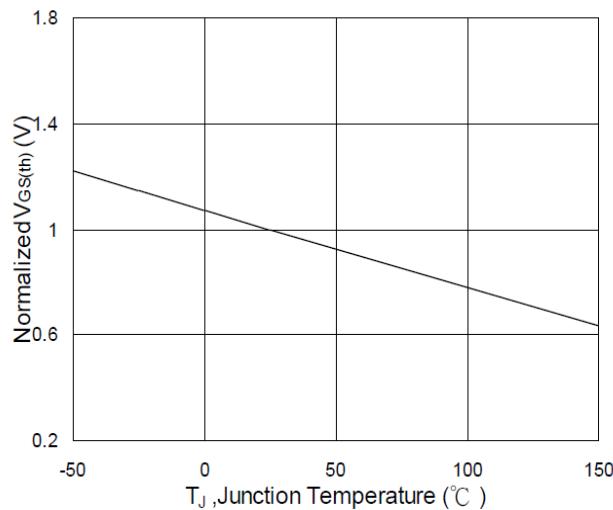
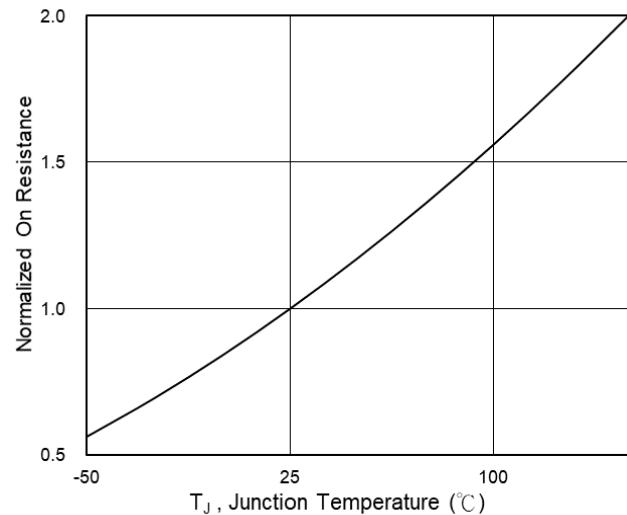
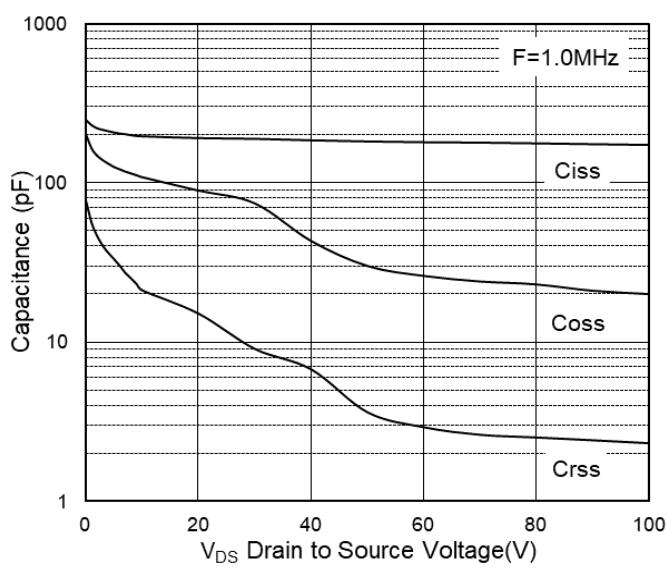
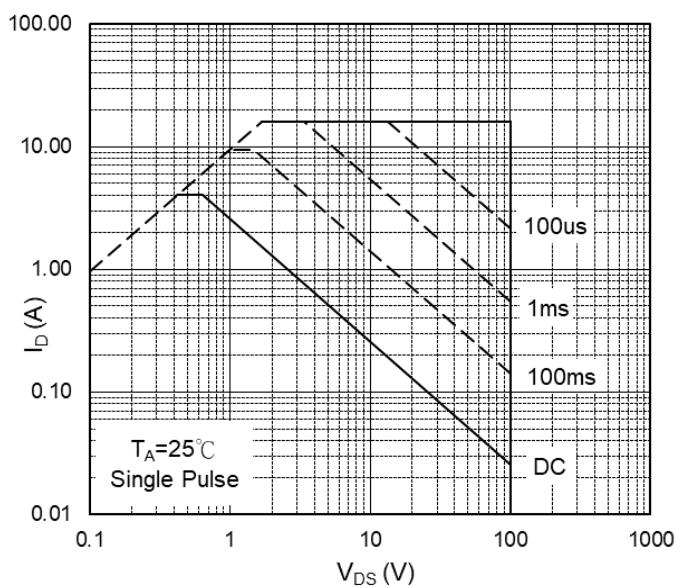


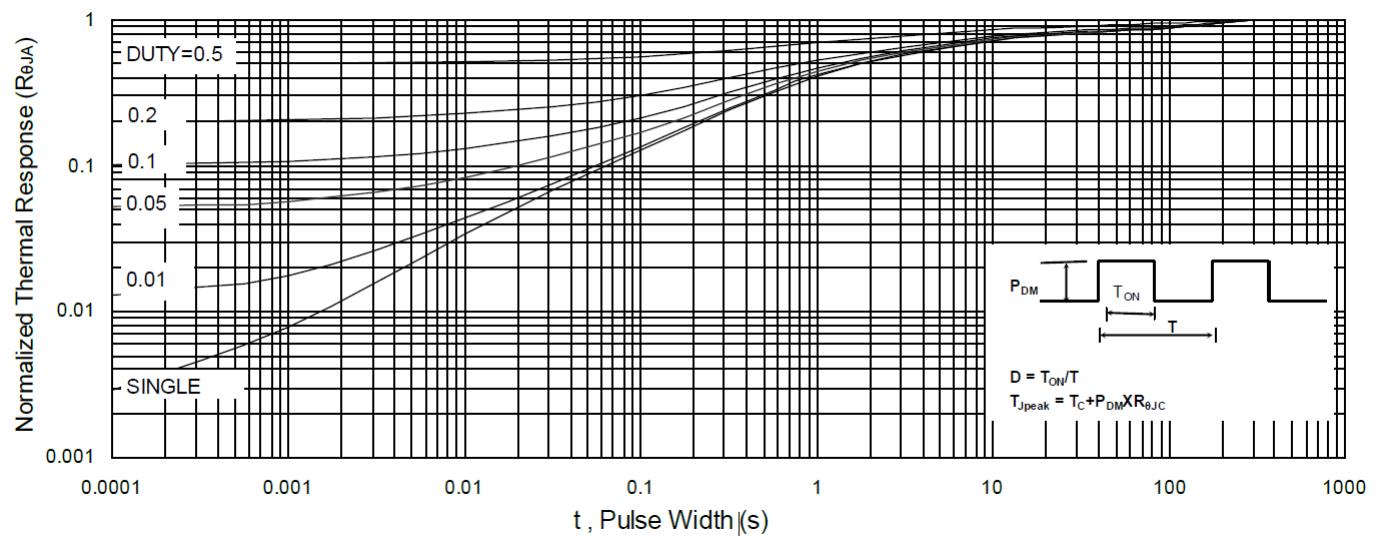
Source Drain Forward Characteristics

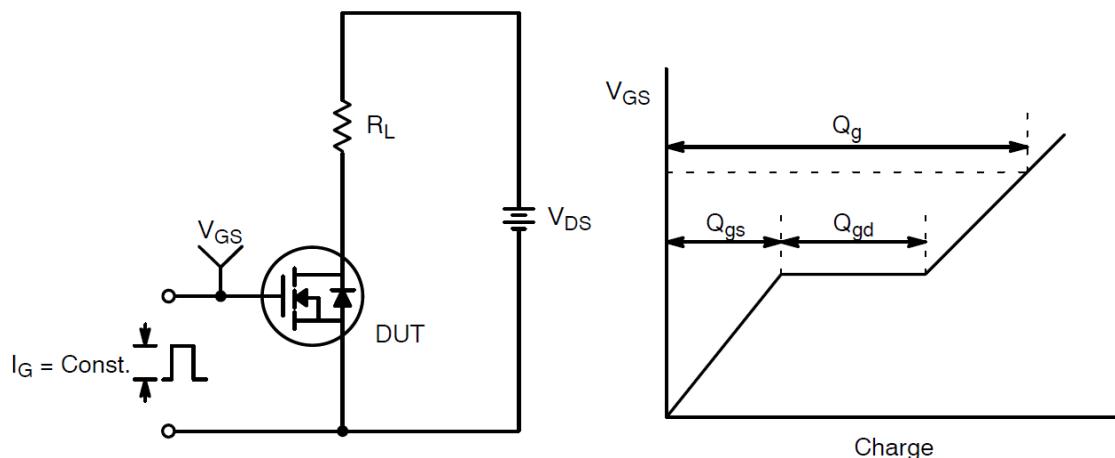
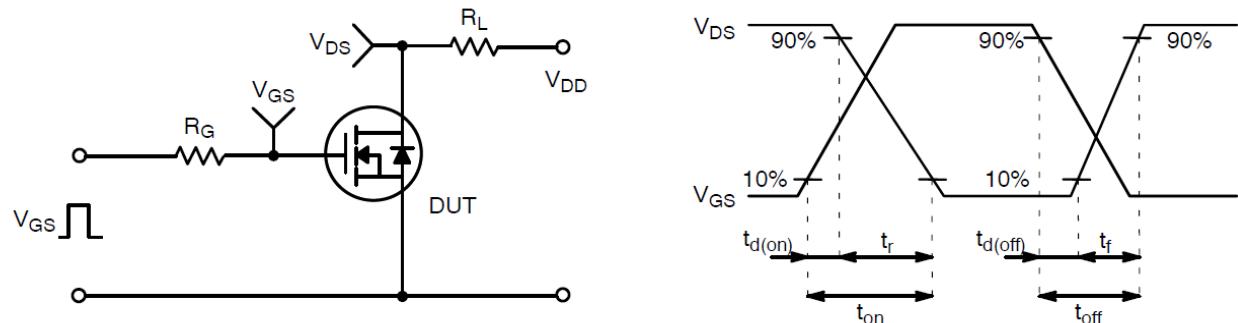
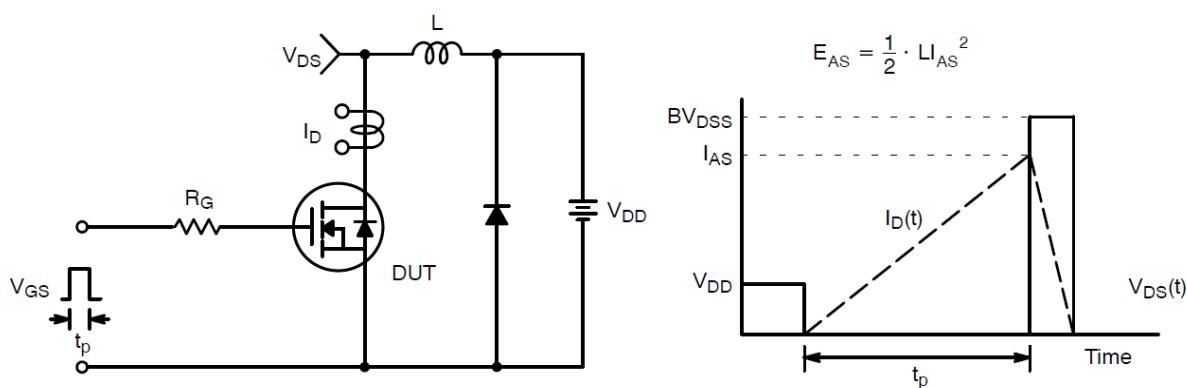


Gate-Charge Characteristics

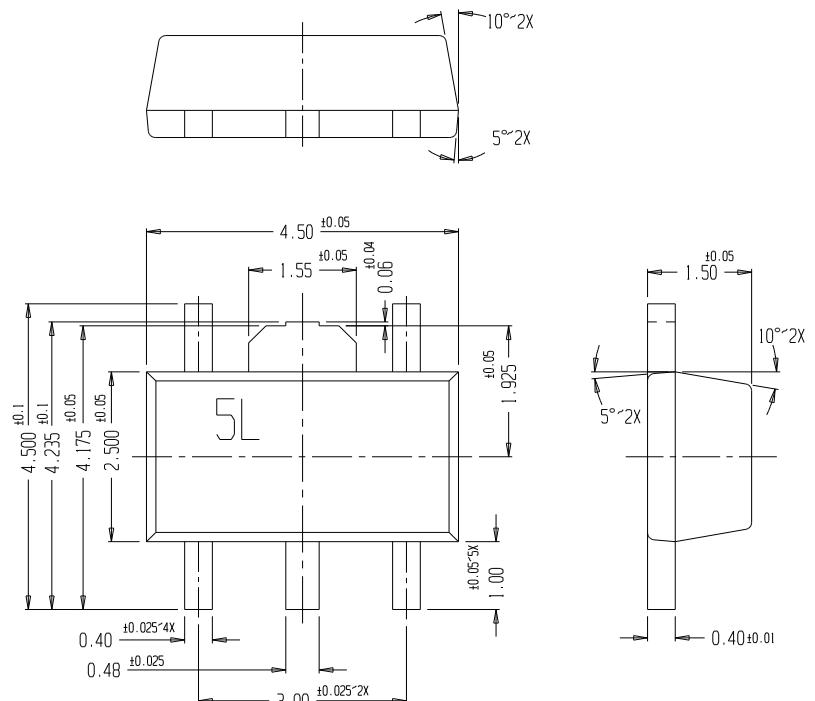
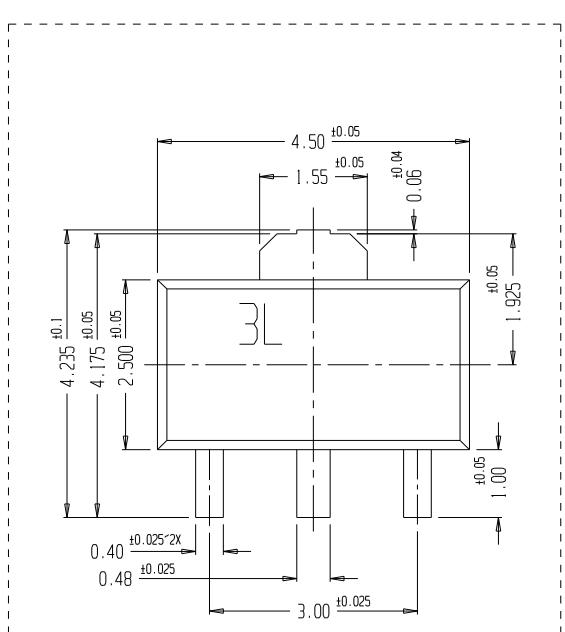


Normalized $V_{GS(th)}$ vs T_J

Normalized $R_{DS(on)}$ vs T_J

Capacitance

Safe Operating Area


Max. transient thermal impedance

Test Circuit and Waveform:

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching Test Circuit & Waveforms

SOT-89 package outline dimensions



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